

Electrical Characteristics (Continued)

Digital Levels and DC Specifications: ADC0816CJ— $4.5V \leq V_{CC} \leq 5.5V$, $-55^{\circ}C \leq T_A \leq +125^{\circ}C$ unless otherwise noted. ADC0816CCJ, ADC0816CCN, ADC0817CCN— $4.75V \leq V_{CC} \leq 5.25V$, $-40^{\circ}C \leq T_A \leq +85^{\circ}C$ unless otherwise noted.

Parameter	Conditions	Min	Typ	Max	Units
DATA OUTPUTS AND EOC (INTERRUPT)					
$V_{OUT(1)}$	Logical "1" Output Voltage $I_O = -360 \mu A$, $T_A = 85^{\circ}C$ $I_O = -300 \mu A$, $T_A = 125^{\circ}C$	$V_{CC}-0.4$			V
$V_{OUT(0)}$	Logical "0" Output Voltage $I_O = 1.6 \text{ mA}$			0.45	V
$V_{OUT(0)}$	Logical "0" Output Voltage EOC $I_O = 1.2 \text{ mA}$			0.45	V
I_{OUT}	TRI-STATE® Output Current $V_O = V_{CC}$ $V_O = 0$	-3.0		3.0	μA μA

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Timing Specifications: $V_{CC} = V_{REF(+)} = 5V$, $V_{REF(-)} = GND$, $t_r = t_f = 20 \text{ ns}$ and $T_A = 25^{\circ}C$ unless otherwise noted.

Symbol	Parameter	Conditions	Min	Typ	Max	Units
t_{WS}	Minimum Start Pulse Width	(Figure 5) (Note 7)		100	200	ns
t_{WALE}	Minimum ALE Pulse Width	(Figure 5)		100	200	ns
t_s	Minimum Address Set-Up Time	(Figure 5)		25	50	ns
t_H	Minimum Address Hold Time	(Figure 5)		25	50	ns
t_D	Analog MUX Delay Time from ALE	$R_S = 0\Omega$ (Figure 5)		1	2.5	μs
t_{H1}, t_{H0}	OE Control to Q Logic State	$C_L = 50 \text{ pF}$, $R_L = 10k$ (Figure 8)		125	250	ns
t_{1H}, t_{0H}	OE Control to Hi-Z	$C_L = 10 \text{ pF}$, $R_L = 10k$ (Figure 8)		125	250	ns
t_c	Conversion Time	$f_c = 640 \text{ kHz}$, (Figure 5) (Note 8)	90	100	116	μs
f_c	Clock Frequency		10	640	1280	kHz
t_{EOC}	EOC Delay Time	(Figure 5)	0		$8 + 2 \mu s$	Clock Periods
C_{IN}	Input Capacitance	At Control Inputs		10	15	pF
C_{OUT}	TRI-STATE Output Capacitance	At TRI-STATE Outputs (Note 8)		10	15	pF

Note 1: Absolute maximum ratings are those values beyond which the life of the device may be impaired.

Note 2: All voltages are measured with respect to GND, unless otherwise specified.

Note 3: A zener diode exists, internally, from V_{CC} to GND and has a typical breakdown voltage of $7 V_{DC}$.

Note 4: Two on-chip diodes are tied to each analog input which will forward conduct for analog input voltages one diode drop below ground or one diode drop greater than the V_{CC} supply. The spec allows 100 mV forward bias of either diode. This means that as long as the analog V_{IN} does not exceed the supply voltage by more than 100 mV, the output code will be correct. To achieve an absolute $0 V_{DC}$ to $5 V_{DC}$ input voltage range will therefore require a minimum supply voltage of $4.900 V_{DC}$ over temperature variations, initial tolerance and loading.

Note 5: Total unadjusted error includes offset, full-scale, and linearity errors. See Figure 3. None of these A/Ds requires a zero or full-scale adjust. However, if an all zero code is desired for an analog input other than 0.0V, or if a narrow full-scale span exists (for example: 0.5V to 4.5V full-scale) the reference voltages can be adjusted to achieve this. See Figure 13.

Note 6: Comparator input current is a bias current into or out of the chopper stabilized comparator. The bias current varies directly with clock frequency and has little temperature dependence (Figure 6). See paragraph 4.0.

Note 7: If start pulse is asynchronous with converter clock the minimum start pulse width is 8 clock periods plus $2 \mu s$.

Note 8: The outputs of the data register are updated one clock cycle before the rising edge of EOC.